# ELECTRONIC SUPPLEMENTARY INFORMATION

# Non-aqueous sol-gel synthesis of hybrid rare-earth-doped $\gamma$ -Ga<sub>2</sub>O<sub>3</sub> nanoparticles with multiple organic-inorganic-ionic light-emission features

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### Materials & Methods:

All chemicals were purchased from Sigma-Aldrich (benzyl alcohol anhydrous 99.8%, gallium(III) acetylacetonate 99.99%) and ABCR (europium(III) acetate hydrate 99.99%) and used as received without further purification. Powder preparation were performed in a glove box with  $O_2 < 0.1$  ppm and  $H_2O < 0.1$  ppm.

TEM measurements were made on a Philips FEI Tecnai F30 microscope operated at 300 kV on samples prepared by depositing onto carbon coated Cu grids 10 µL of ethanol (Aldrich) suspension of washed NPs. X-ray diffraction (XRD) measurements were performed in reflection mode (Cu Ka radiation at 45 kV and 40 mA) either on a X'Pert Pro diffractometer or on an Empyrean diffractometer (equipped with a high temperature chamber model HTK 1200 from Anton Paar), both from PANalytical (The Netherlands). Differential scanning calorimetry and thermogravimetry analysis were performed on a Netzsch DSC 449F3 thermoanalyzer; samples were prepared by placing nanopowders in Pt crucibles with a lid, and measured in Ar flux against empty Pt crucibles as a reference with a heating rate of 10 °C/min<sup>-1</sup>. Raman spectra were collected in backscattering configuration using an inVia Renishaw spectrometer and a 785 nm laser line as light source. Steady-state photoluminescence has been measured using a FP-8500 by Jasco. The data were corrected for the spectral response of the detection system and the spectral shape of the light source. Time-resolved photoluminescence has been carried out with a FLS 980 spectrofluorometer and using an EPLED by Edinburgh Photonics operating at 340 nm with pulse duration of about 900 ps as light source. Slow component of time-resolved (i.e. intrinsic lifetime of Eu ions) photoluminescence measurements were performed at RT using a Varian Eclipse spectrofluorometer and a pulsed Xenon lamp as light source.

### **XRD** patterns:



Fig. S1: XRD patterns of Ga<sub>2</sub>O<sub>3</sub> nanopowder before (blue line) and after (red line) thermal treatment at 420 °C for 1 h.

## Fitting results on lifetime measurements:



Fig. S2: lifetime measurements and relative fitting curves (black lines) of as-synthesized (blue triangles) and heat treated at 420 °C for 1 h (red circles) samples exciting at 290 nm and monitoring the luminescence at 620 nm.

	а	b	$\tau_1$ (µs)	$\tau_2(\mu s)$
Untreated sample	0.810	0.346	320	697
420 °C, 1 h	0.615	0.463	312	1160

Table S1: fitting results of lifetime measurements reported in Fig. S2, data have been fitted using the following biexponential formula:

$$f(t) = a \exp\left(-\frac{t}{\tau_1}\right) + b \exp\left(-\frac{t}{\tau_2}\right)$$